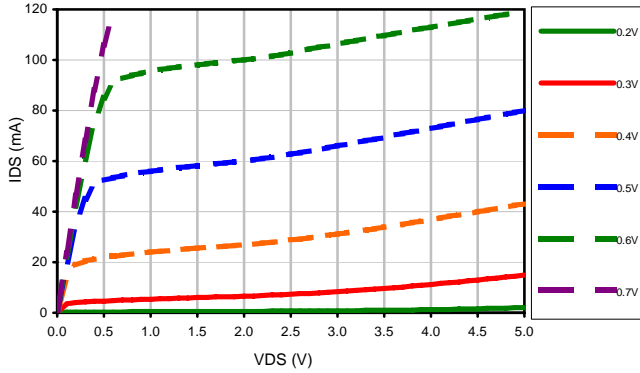
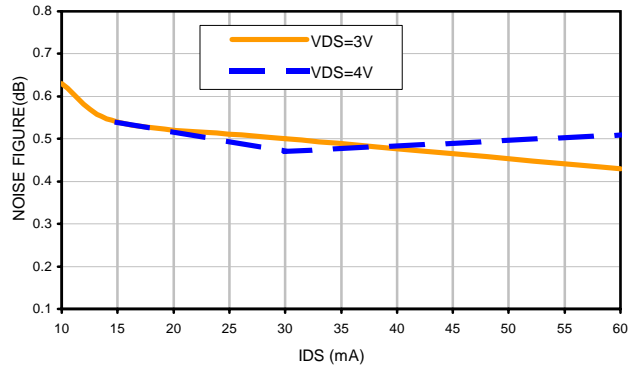


Typical Performance Curves

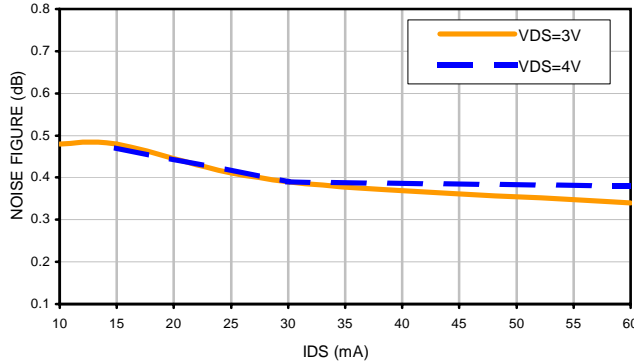
I-V (VGS=0.1V PER STEP) (2)



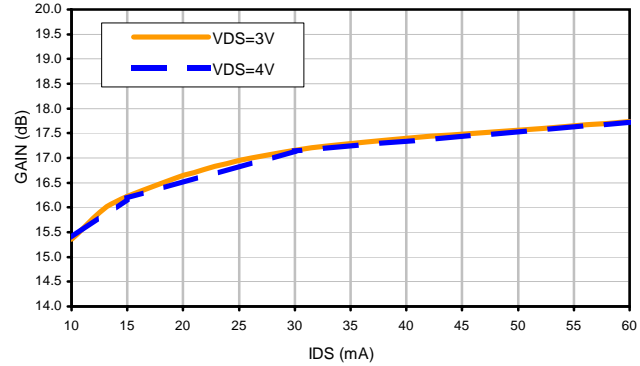
NOISE FIGURE vs IDS @ 2 GHz (1)



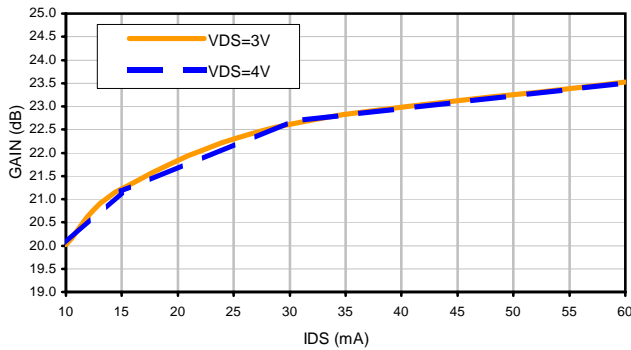
NOISE FIGURE vs IDS @ 0.9 GHz (1)



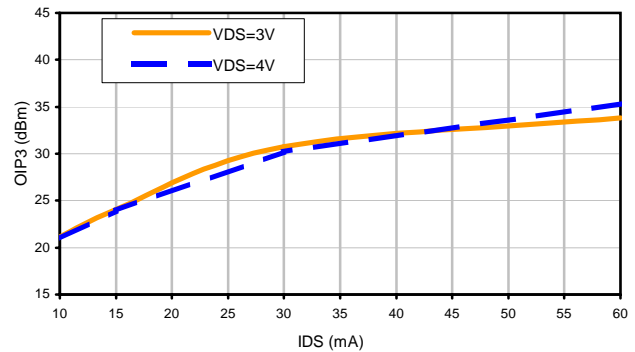
GAIN vs IDS @ 2 GHz (1)



GAIN vs IDS @ 0.9 GHz (1)



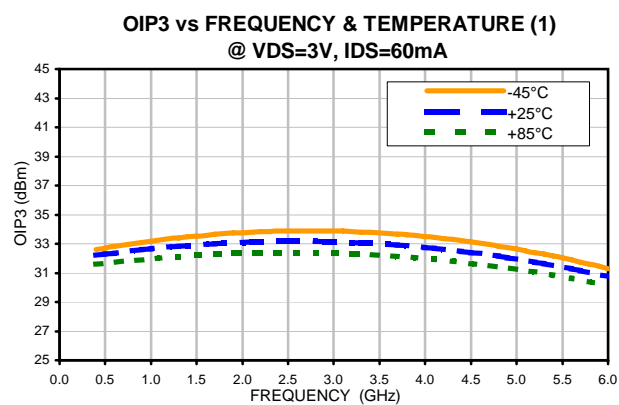
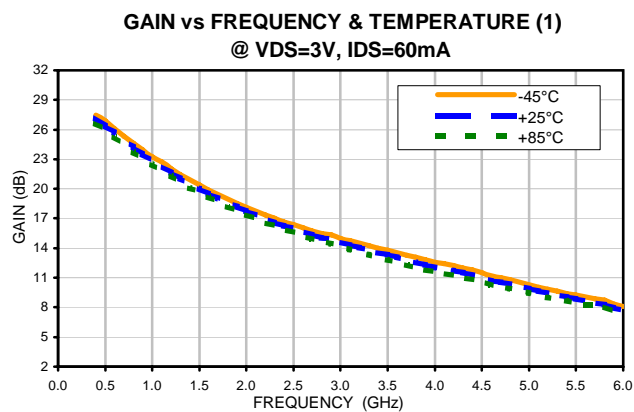
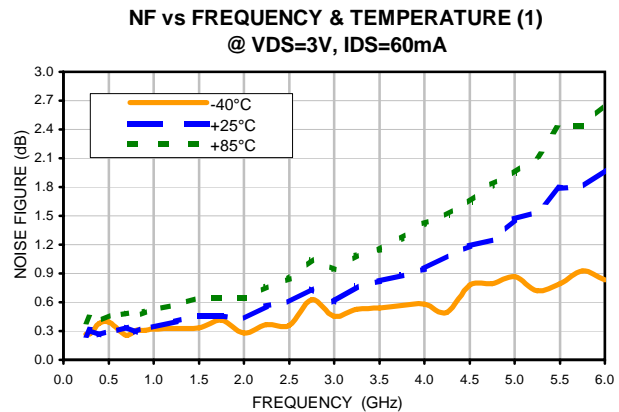
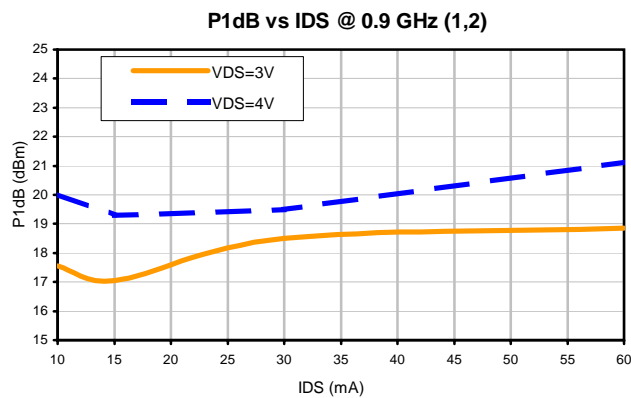
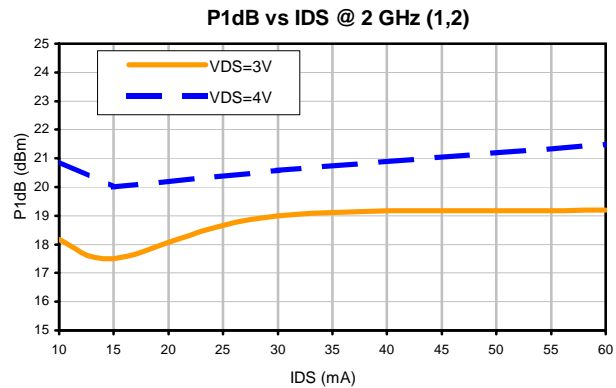
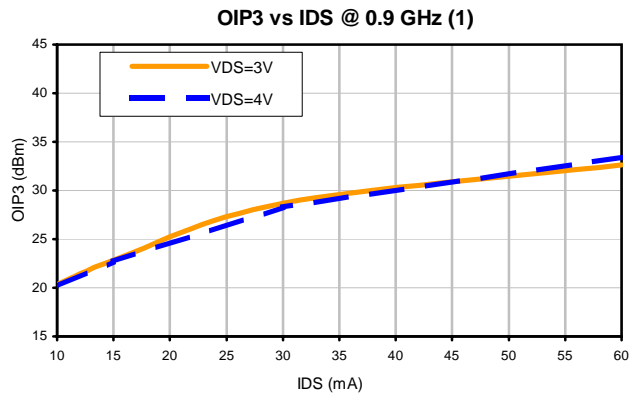
OIP3 vs IDS @ 2GHz (1)



(1) Includes test board loss

(2) Measured using HP4155B semiconductor parameter analyzer

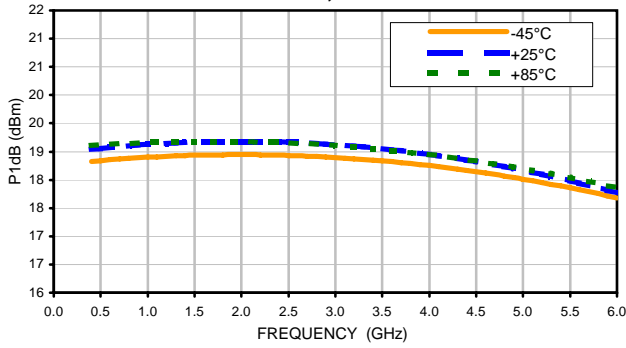
Typical Performance Curves



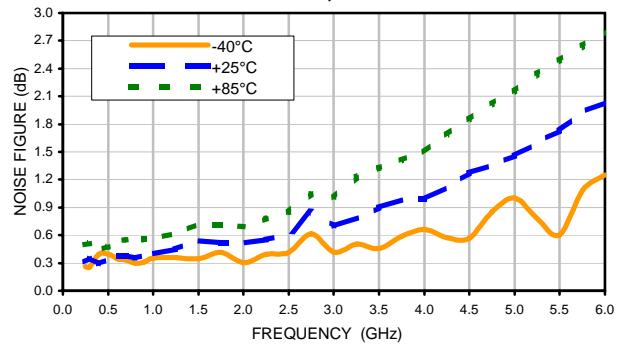
- (1) Includes test board loss
- (2) Drain current was allowed to increase during compression measurement

Typical Performance Curves

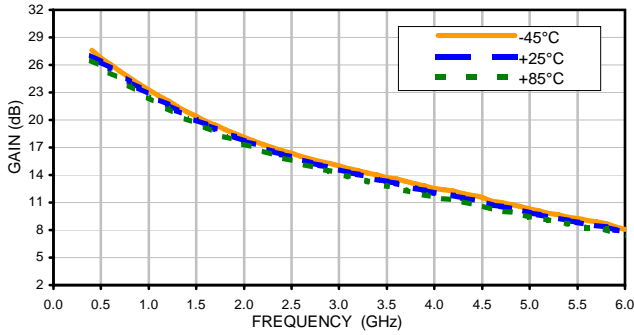
P1dB vs FREQUENCY & TEMPERATURE (1,2)
@ VDS=3V, IDS=60mA



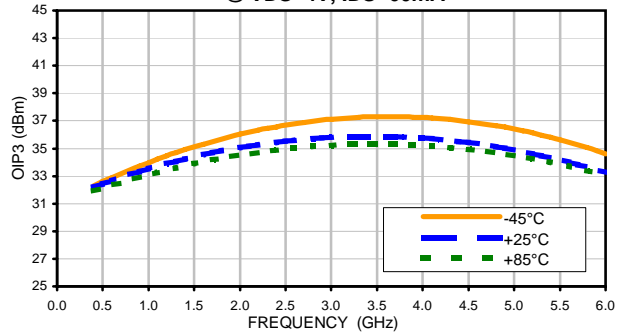
NF vs FREQUENCY & TEMPERATURE (1)
@ VDS=4V, IDS=60mA



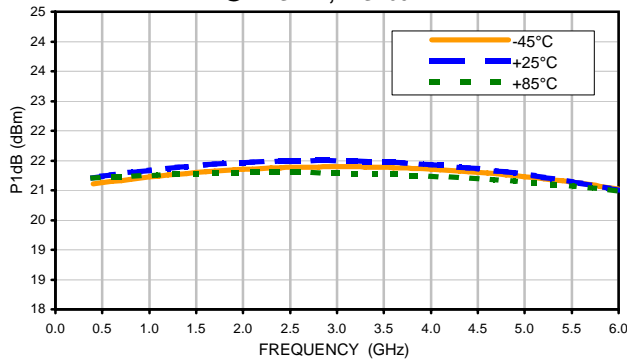
GAIN vs FREQUENCY & TEMPERATURE (1)
@ VDS=4V, IDS=60mA



OIP3 vs FREQUENCY & TEMPERATURE (1)
@ VDS=4V, IDS=60mA

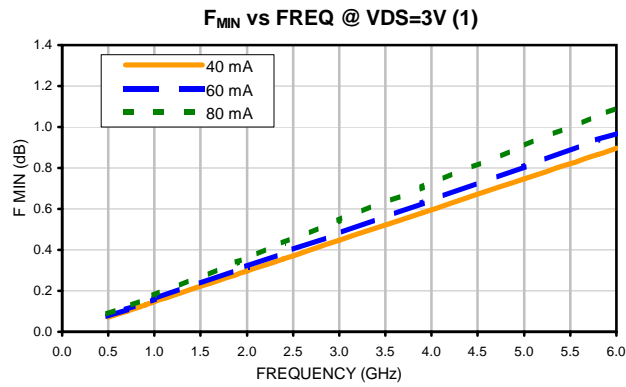
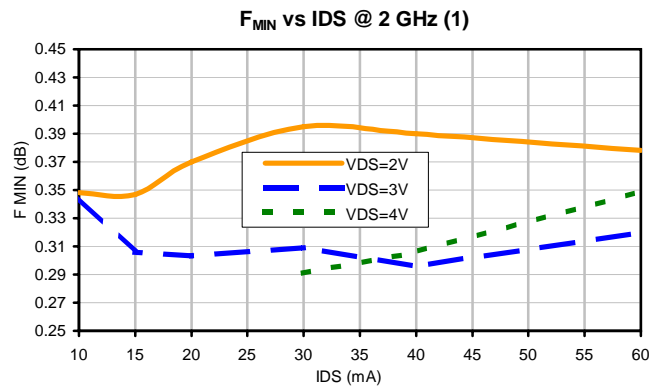
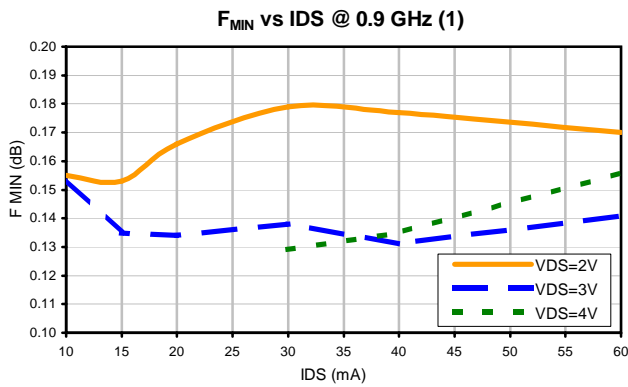


P1dB vs FREQUENCY & TEMPERATURE (1,2)
@ VDS=4V, IDS=60mA



- (1) Includes test board loss
- (2) Drain current was allowed to increase during compression measurement

Typical Performance Curves



(1) F_{MIN} is minimum Noise Figure